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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO	
09/586,518	06/02/2000	Michael R. Bruce	AMDA.455PA	5747	
75	590 11/18/2002				
Crawford PLLC			EXAMINER		
1270 Northland Drive Suite 390 ST. Paul, MN 55120			монамер,	MOHAMED, CHARIOUI	
			ART UNIT	PAPER NUMBER	
			2857		
			DATE MAILED: 11/18/2002	DATE MAILED: 11/18/2002	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)	. 1)				
Office Action Summary		09/586,518	BRUCE ET AL.					
		Examiner	Art Unit					
		Mohamed Charioui	2857	 				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply								
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status								
1)[🛛	Responsive to communication(s) filed on 24 S	eptember 2002 .						
2a)□		s action is non-final.						
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Dispositi	on of Claims	expans gadyis, roos c.s. 11, 1						
4)⊠	Claim(s) 1-23 is/are pending in the application.							
•	4a) Of the above claim(s) is/are withdrawn from consideration.							
5)⊠ Claim(s) <u>17</u> is/are allowed.								
6)⊠	6)⊠ Claim(s) <u>1-3,6-16 and 18-23</u> is/are rejected.							
·	7)⊠ Claim(s) <u>4 and 5</u> is/are objected to.							
8) Claim(s) are subject to restriction and/or election requirement. Application Papers								
	The specification is objected to by the Examiner							
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.								
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).								
11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.								
If approved, corrected drawings are required in reply to this Office action.								
12) ☐ The oath or declaration is objected to by the Examiner.								
Priority under 35 U.S.C. §§ 119 and 120								
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).								
a) ☐ All b) ☐ Some * c) ☐ None of:								
	1. Certified copies of the priority documents have been received.							
	2. Certified copies of the priority documents have been received in Application No							
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 								
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).								
a) ☐ The translation of the foreign language provisional application has been received. 15)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.								
Attachment		. , ,						
2) Notice	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Informal I	/ (PTO-413) Paper No(s Patent Application (PTO					

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DETAILED ACTION

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Drawings

1. Fig. 1 is objected to because the elements in the figure are not labeled.

See 37 CFR 184(n) and 37 CFR 184(o)

(n) Symbols. Graphical drawing symbols may be used for conventional elements

when appropriate. The elements for which such symbols and labeled representations

are used must be adequately identified in the specification. Known devices should be

illustrated by symbols which have a universally recognized conventional meaning and

are generally accepted in the art. Other symbols which are not universally recognized

may be used, subject to approval by the Office, if they are not likely to be confused with

existing conventional symbols, and if they are readily identifiable.

(o) Legends. Suitable descriptive legends may be used, or may be required by

the Examiner, where necessary for understanding of the drawing, subject to approval by

the Office. They should contain as few words as possible.

Applicant is required to label all the boxes in drawing of Fig. 1.

Claim Objections

2. Claim 21 is objected to because of the following informalities: "." is missing at

the end of the claim. Appropriate correction is required.

Claim Rejections - 35 USC § 102

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that

form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

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(e) the invention was described in a patent granted on an application for patent by another filed in the United States before the invention thereof by the applicant for patent, or on an international application by another who has fulfilled the requirements of paragraphs (1), (2), and (4) of section 371(c) of this title before the invention thereof by the applicant for patent.

The changes made to 35 U.S.C. 102(e) by the American Inventors Protection Act of 1999 (AIPA) do not apply to the examination of this application as the application being examined was not (1) filed on or after November 29, 2000, or (2) voluntarily published under 35 U.S.C. 122(b). Therefore, this application is examined under 35 U.S.C. 102(e) prior to the amendment by the AIPA (pre-AIPA 35 U.S.C. 102(e)).

Claims 1-3, 6-16 and 18-23 are rejected under 35 U.S.C. 102(e) as being anticipated by Nikawa.

As per claim 1, Nikawa teaches a method for analyzing a semiconductor die having suspect circuitry that includes a multitude of circuit paths, using a state-changing operation of the suspect circuitry to cause a failure due to the suspect circuitry, identifying one of the circuit paths that electrically changes in response to heat and detecting that a particular circuit portion therein is resistive (see col. 4, lines 12-38 and col. 8, line 56 to col. 9, line 2).

As per claims 2, 3, 6-8, 11-14, 18, Nikawa further teaches heating at least a selected portion of state-changing circuitry in the semiconductor die to cause a failure due to suspect circuitry, the state-changing circuitry including a suspect signal path site (see col. 4, lines 12-38 and col. 8, line 56 to col. 9, line 2); detecting, in response to the selected portion being heated, a state-changing transition between a failed mode and a recovered mode in the suspect signal path site (see col. 15, line 46 to col. 16, line 38); using the detected state-changing transition, determining that the signal path site has a

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resistivity (i.e. change in current is proportional to the change in resistivity) that changes between the failed mode and the recovered mode (see col. 16, lines 25-38; col. 2, lines 8-59; and Fig. 2).

As per claims 15 and 19, Nikawa further teaches using a scanning optical microscope (see col. 9, lines 45-60 and col. 10, lines 21-30).

As per claims 16, 20 and 21, Nikawa further teaches placing the die in a test arrangement adapted to electrically operate the die under selected operating conditions and to obtain a response from the die including the state-changing transition (see col. 8, line 46 to col. 9, line 45).

Claim Rejections - 35 USC § 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claim 9 is rejected under 35 U.S.C. 103(a) as being unpatentable over Nikawa in view of Yue et al.

Nikawa teaches the system as stated above except that identifying one of the circuit paths that electrically changes in response to heat includes detecting a change in a failure rate of the circuit path during a state-changing operation. Yue et al. teach this feature (see col. 5, lines 33-40 and col. 1, lines 32-46). It would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate Yue et al.'s teaching into Nikawa's invention, because the detection of change in failure

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rate during a state-changing operation would determine if the failure rate increase or decreases during that state-changing operation an therefore would indicate defects in the die.

Claims 10, 22 and 23 is rejected under 35 U.S.C. 103(a) as being unpatentable over Nikawa in view of Paniccia et al.

As per claim 10, Nikawa teaches the system as stated above except for thinning the die prior to the heating. Paniccia et al. teach this feature (see col. 5, lines 7-23). It would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate Paniccia et al.'s teaching into Nikawa's invention, because thinning the die would increase the transmission of the laser beam into the die; therefore, the current varies as well as the resistivity which determine the presence of a failure in the die.

As per claims 22 and 23, Nikawa teaches the system as stated above except for a photodetector adapted to detect reflected light from the die as it is scanned with the laser and to provide a signal representing the detected light to the display. Paniccia et al. teach this feature (see col. 6, lines 38-65). It would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate Paniccia et al. 's teaching into Nikawa's invention, because it would detect a change in the reflected light that leads to a change in voltage and current in the die and consequently a change of resistivity would be detected.

Allowable Subject Matter

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5. Claims 4, 5 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The following is a statement of reasons for the indication of allowable subject matter: none of the prior art of record teaches or suggests electrically operating the die in a loop that causes the die to fail at a selected failure rate.

Claim 17 is allowed.

The following is a statement of reasons for the indication of allowable subject matter: none of the prior art of record teaches or suggests electrically operating the die in a loop that causes the die to fail at a selected failure rate.

Prior art

6. The prior art made record and not relied upon is considered pertinent to applicant's disclosure:

Wu ['039] discloses a functional Optical Beam induced Current (OBIC) analysis.

Boyington et al. ['897] disclose a method and system for dynamic duration burn-in.

Morant ['776] discloses a non-intrusive testing of a terminal resistor.

Response to Arguments

7. Applicant's arguments with respect to claims 1-23 have been considered but are most in view of the new ground(s) of rejection.

Applicant argues that the reference numerals are consistent with the requirement set forth in 37 CFR §1.84(p). Examiner's objection to the drawing is appropriate See 37 CFR 184(n) and 37 CFR 184(o).

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Contact information

8. Any inquiry concerning this communication from examiner should be directed to Mohamed Charioui whose telephone number is 703 605-4362. The examiner can normally be reached Monday to Friday 9 am to 6 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Marc S. Hoff can be reached at 703 308-1677. The fax phone number for the organization where this application is assigned is 703 305-3431.

Any inquiry of a general nature or relating to the status of this application should be directed to the group receptionist whose number is 703 308-0956.

Mohamed Charioui

November 7th, 2002

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